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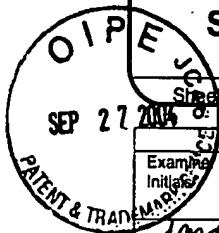
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Sheet 1 of 1

Application Number	09/800,627
Filing Date	March 7, 2001
First Named Inventor	Tanaka et al.
Art Unit	2822
Examiner Name	T. Thomas
Attorney Docket Number	SEL 245

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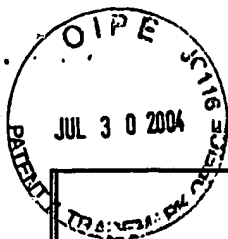
Examiner Signature	T. M. Thomas	Date Considered	11-12-04
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LIST OF PUBLICATIONS CITED BY APPLICANT			Atty. Docket No. SEL 245		Serial No. 09/800,627	
			Applicant Koichiro TANAKA et al			
			Filing Date March 7, 2001		Group 2822	
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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

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